

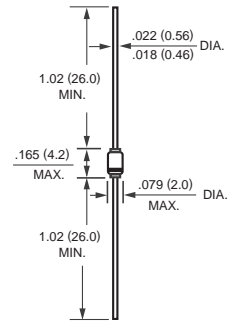
**SILICON PLANAR SCHOTTKY
BARRIER DIODE**

FEATURES

- * Fast Switching Device($T_{RR}<4.0nS$)
- * DO-34 Package (JEDEC)
- * Through-Hole Device Type Mounting
- * Hermetically Sealed Glass
- * Compression Bonded Construction
- * All external surfaces are corrosion resistant and leads are readily solderable

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified.
Single phase, half wave, 60 Hz, resistive or inductive load.
For capacitive load, derate current by 20%.



Dimensions in inches and (millimeters)

MAXIMUM RATINGS (@ $T_A = 25^\circ C$ unless otherwise noted)

RATINGS	SYMBOL	BAT86	UNITS
Maximum Forward Continuous Reverse Voltage	V_R	50	V
Maximum Forward Continuous Current @ $T_A=25^\circ C$	I_F	200	mAmps
Repetitive Peak Forward Current $t_p \leq 1s; \delta \leq 0.5$	I_{FRM}	500	AmpsR
Surge Forward Current @ $t_p \leq 10ms$	I_{FSM}	5	mAmps
Junction Temperature	T_J	125	$^\circ C$
Storage Temperature Range	T_{STG}	-65 to + 150	$^\circ C$

ELECTRICAL CHARACTERISTICS (@ $T_A = 25^\circ C$ unless otherwise noted)

CHARACTERISTICS	SYMBOL	MIN.	TYP.	MAX.	UNITS
Reverse breakdown voltage ($I_R=10\mu A$)	$V_{(BR)R}$	50	-	-	V
Reverse voltage leakage current ($V_R=40V$)	I_R	-	-	5.0	μA
Forward voltage Pulse Test $t_p < 300\mu s, \delta < 2\%$	V_F	-	-	0.30	V
($I_F=0.1mA$)				0.38	
($I_F=1mA$)				0.45	
($I_F=10mA$)				0.60	
($I_F=30mA$)				0.90	
($I_F=100mA$)					
Diode capacitance ($V_R=1, f=1MHz$)	C_D	-	-	8.0	pF
Reverse recovery time ($I_F=I_R=10mA, R_L=100\Omega, I_R=1mA$)	t_{rr}	-	-	4.0	nS